

United States Patent and Trademark Office

UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, Virginia 22313-1450 www.uspto.gov

APPLICATION NO.	FILI	NG DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/625,630	07/	24/2003	Akiyoshi Tamura	L8462.03106	9060
24257	7590	02/18/2005		EXAM	INER
STEVENS DAVIS MILLER & MOSHER, LLP				HUYNH, ANDY	
1615 L STR SUITE 850	,			ART UNIT	PAPER NUMBER
WASHING	TON, DC 2	20036		2818	
		•		DATE MAILED: 02/18/200	5

Please find below and/or attached an Office communication concerning this application or proceeding.

·			4.12
	Application No.	Applicant(s)	, ,
	10/625,630	TAMURA ET AL.	
Office Action Summary	Examiner	Art Unit	
	Andy Huynh	2818	
The MAILING DATE of this communication Period for Reply	appears on the cover sheet w	vith the correspondence address	
A SHORTENED STATUTORY PERIOD FOR RE THE MAILING DATE OF THIS COMMUNICATIO - Extensions of time may be available under the provisions of 37 CFF after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a - If NO period for reply is specified above, the maximum statutory per - Failure to reply within the set or extended period for reply will, by state of the second part of the mean patent term adjustment. See 37 CFR 1.704(b).	N. R 1.136(a). In no event, however, may a reply within the statutory minimum of th riod will apply and will expire SIX (6) MC atute, cause the application to become	a reply be timely filed nirty (30) days will be considered timely. DNTHS from the mailing date of this communication. ABANDONED (35 U.S.C. § 133).	
Status			
1) Responsive to communication(s) filed on 2	<u> 1 December 2004</u> .		
2a) ☐ This action is FINAL . 2b) ☒ T	This action is non-final.		
3) Since this application is in condition for allo closed in accordance with the practice under			
Disposition of Claims			
4) ⊠ Claim(s) <u>15-28</u> is/are pending in the application 4a) Of the above claim(s) is/are with the state of the above claim(s) is/are allowed. 5) □ Claim(s) <u>15-28</u> is/are rejected. 7) □ Claim(s) is/are objected to. 8) □ Claim(s) are subject to restriction and	drawn from consideration.		
Application Papers			
9) The specification is objected to by the Exam 10) The drawing(s) filed on 24 July 2003 is/are: Applicant may not request that any objection to Replacement drawing sheet(s) including the cor 11) The oath or declaration is objected to by the	a)⊠ accepted or b)⊡ obje the drawing(s) be held in abey rrection is required if the drawir	ance. See 37 CFR 1.85(a). ng(s) is objected to. See 37 CFR 1.121(d).	
,			
Priority under 35 U.S.C. § 119 12) Acknowledgment is made of a claim for force a) All b) Some * c) None of: 1. Certified copies of the priority document of the priority	nents have been received. nents have been received in priority documents have bee reau (PCT Rule 17.2(a)).	Application No en received in this National Stage	
Attachment(s) 1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB Paper No(s)/Mail Date	Paper N	v Summary (PTO-413) o(s)/Mail Date f Informal Patent Application (PTO-152) 	

Art Unit: 2818

DETAILED ACTION

In the Amendment filed 12/21/2004, claims 1-14 are canceled and new claims 15-28 are added are acknowledged. Accordingly, claims 15-28 are currently pending in the application.

Response to Arguments

Applicant's arguments with respect to claims 15-28 have been considered but are moot in view of the new ground(s) of rejection.

Claim Rejections - 35 USC § 112

The following is a quotation of the first paragraph of 35 U.S.C. 112:

The specification shall contain a written description of the invention, and of the manner and process of making and using it, in such full, clear, concise, and exact terms as to enable any person skilled in the art to which it pertains, or with which it is most nearly connected, to make and use the same and shall set forth the best mode contemplated by the inventor of carrying out his invention.

Claims 15-20 are rejected under 35 U.S.C. 112, first paragraph, as failing to comply with the written description requirement. The claim(s) contains subject matter which was not described in the specification in such a way as to reasonably convey to one skilled in the relevant art that the inventor(s), at the time the application was filed, had possession of the claimed invention.

Applicant introduces the new matter by adding:

"a gate electrode extending from the surface of said epitaxial substrate to said buffer layer" into claims 15 and 19.

Art Unit: 2818

The added matter(s) is(are) not supported in the Specification and it (they) (is) are not satisfactory resolved and consequently raise doubt as to possession of the claimed invention at the time of filing.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 21-24 and 27 are rejected under 35 U.S.C. 103(a) as being unpatentable over Inata et al. (USP 4,593,301 hereinafter referred to as "Inata") in view of Nakamura Toshihiro (JP 03-250742 hereinafter referred to as "Nakamura").

Regarding claims 21 and 24, Inata discloses in Fig. 7 and the corresponding texts as set forth in column 5, line 60-column 7, line 15, a method of manufacturing a heterojunction field effect transistor/a high electron mobility transistor (HEMT), the method comprising:

epitaxially forming a composite substrate, having a plurality of semiconductor layers on a semi-insulative substrate 11, the semiconductor layers including a semiconductor layer that serves as an active layer/a GaAs channel layer 12A and at least one other semiconductor layer, formed over the upper side or both over the upper side and under the lower side of said active layer, that serves as an N-type carrier supply layer/an N-type AlGaAs 15 for supplying an electron to said active layer/the GaAs channel layer;

Art Unit: 2818

forming a gate electrode 20 on said composite substrate; and forming N-type source and drain areas 17, by carrying out:

ion injection for forming N-type semiconductors in predetermined areas of said composite substrate, each of said source and drain areas formed to one side of said gate electrode, and

an annealing process for activating the ion injected areas.

Inata fails to teach said upper-side N-type carrier supply layer, between said source area and said drain area, is doped with Selenium (Se) or Tellurium (Te), or at least one of said upper-and lower-side N-type carrier supply layers, between said source area and said drain area, is doped with Selenium (Se) or Tellurium (Te). Nakamura teaches in Fig. 1 a semiconductor device comprises an electron/carrier supply layer 5 is doped with Selenium (Se) to obtain a high-speed semiconductor device whose carrier mobility is high and whose carrier concentration distribution inside the substrate face is uniform as set forth in the English Abstract. It would have been obvious to one having ordinary skill in the art at the time of the invention was made to form an electron/carrier supply layer doped with Selenium (Se), as taught by Nakamura in order to obtain a high-speed semiconductor device whose carrier mobility is high and whose carrier concentration distribution inside the substrate face is uniform.

Regarding claims 22 and 23, Inata and Nakamura disclose the all claimed limitations except for the active layer is formed of InGaAs and said upper-side N-type carrier supply layer is formed of InAlAs or at least one of said upper- and lower-side N-type carrier supply layers is formed of InAlAs. It would have been obvious to one having ordinary skill in the art at the time of the invention was made to form an InGaAs layer as the active layer and the N-type carrier

Art Unit: 2818

supply layer formed of InAlAs, since it has been held to be within the general skill of a worker in the art to select a known material on the basis of its suitability for the intended use as a matter of obvious design choice. In re Leshin, 125 USPQ 416.

Regarding claim 27, Inata discloses the annealing process for activating the ion injected areas is carried out in a manner of lamp annealing (col. 6, lines 12-20).

Claims 25, 26 and 28 are rejected under 35 U.S.C. 103(a) as being unpatentable over Inata et al. (USP 4,593,301 hereinafter referred to as "Inata") in view of Shakuda (USP 5,825,052).

Regarding claim 25, Inata discloses in Fig. 7 and the corresponding texts as set forth in column 5, line 60-column 7, line 15, a method of manufacturing a heterojunction field effect transistor/a high electron mobility transistor (HEMT), the method comprising:

epitaxially forming a composite substrate, having a plurality of semiconductor layers on a semi-insulative substrate 11, said plurality of semiconductor layers including a semiconductor layer that serves as an N-type active layer/a GaAs channel layer 12A;

forming a gate electrode 20 on said composite substrate; and forming N-type source and drain areas 17, by carrying out:

ion injection for forming N-type semiconductors in predetermined areas of said composite substrate, each of said source and drain areas formed to one side of said gate electrode, and

an annealing process for activating the ion injected areas.

Art Unit: 2818

emitted light.

Inata fails to teach said semiconductor layer serving as said N-type active layer is doped with Selenium (Se) or Tellurium (Te). Shakuda teaches in Fig. 1 a semiconductor light emitting device comprises an active layer 5 is doped with Selenium (Se) or Tellurium (Te) to control the wavelength of emitted light (col. 4, lines 26-30). It would have been obvious to one having ordinary skill in the art at the time of the invention was made to form an active layer doped with Selenium (Se) or Tellurium (Te), as taught by Shakuda in order to control the wavelength of

Regarding claim 26, Inata and Shakuda disclose the all claimed limitations except for said N-type active layer is an InGaAs layer, a GaAs layer, or an InP layer. It would have been obvious to one having ordinary skill in the art at the time of the invention was made to form the N-type active layer being an InGaAs layer, a GaAs layer, or an InP layer, since it has been held to be within the general skill of a worker in the art to select a known material on the basis of its suitability for the intended use as a matter of obvious design choice. In re Leshin, 125 USPQ 416.

Regarding claim 28, Inata discloses the annealing process for activating the ion injected areas is carried out in a manner of lamp annealing (col. 6, lines 12-20).

Conclusion

A shortened statutory period for response to this action is set to expire 3 (three) months and 0 (zero) day from the day of this letter. Failure to respond within the period for response will cause the application to become abandoned (see M.P.E.P 710.02(b)).

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Andy Huynh, (571) 272-1781. The examiner can normally be reached on Monday-Friday from 8:30 AM to 5:00 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, David Nelms can be reached on (571) 272-1787. The Fax number for the organization where this application or proceeding is assigned is (703) 872-9306.

Any inquiry of a general nature or relating to the -status of this application or proceeding should be directed to the receptionist whose phone number is (703) 308-0956.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Ah

02/14/05

Andy Huynh

and Muy Q

Patent Examiner